

**FCC/IC - TEST REPORT**

Report Number : 68.950.18.0312.01 Date of Issue: March 01, 2019

Model : VTA-75

Product Type : 5-in-1 Turntable

Applicant : Innovative Technology Electronics LLC

Address : 1 Channel Drive, Port Washington, NY 11050, USA.

Factory : Yangchun Qianfeng Electronic Technology Co., Ltd.

Address : C1 West, Industry District, Zhanggang Road, Chuncheng,  
Yangchun City, Guangdong Province, China 529600

Test Result : ☒ Positive ☐ Negative

Total pages including  
Appendices : 47

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## 2 Details about the Test Laboratory

### Details about the Test Laboratory

#### Test Site 1

Company name: TÜV SÜD Certification and Testing (China) Co., Ltd. Shenzhen Branch  
Building 12 & 13, Zhiheng Wisdomland Business Park, Nantou Checkpoint  
Road 2, Nanshan District  
Shenzhen 518052  
P.R. China

Telephone: 86 755 8828 6998  
Fax: 86 755 8288 5299

FCC Registration No.: 514049  
IC Registration No.: 10320A -1

### 3 Description of the Equipment Under Test

Product:	5-in-1 Turntable
Model no.:	VTA-75
FCC ID:	2AFHW-VTA75
IC:	9577A-VTA75
Options and accessories:	Adapter
Rating:	5VDC, 1000mA (Supplied by Adapter)
Adapter:	Model: GKYP50100050UL1 Input: 100-240V~50/60Hz, 0.5A Output: 5VDC, 1000mA
RF Transmission Frequency:	2402MHz-2480MHz
No. of Operated Channel:	79
Modulation:	GFSK, $\pi/4$ -DQPSK
Antenna Type:	PIFA antenna
Antenna Gain:	-0.68dBi
Description of the EUT:	The Equipment Under Test (EUT) is a 5-in-1 Turntable operated at 2.4GHz

#### 4 Summary of Test Standards

Test Standards	
FCC Part 15 Subpart C 10-1-2017 Edition	PART 15 - RADIO FREQUENCY DEVICES Subpart C - Intentional Radiators
RSS-Gen Issue 5 April 2018	General Requirements for the Certification of Radio Apparatus
RSS-247 Issue 2 February 2017	Digital Transmission Systems (DTSS), Frequency Hopping Systems (FHSS) and License-Exempt Local Area Network (LE-LAN) Devices

All the test methods were according to Public Notice DA 00-705 -Frequency Hopper Spread Spectrum Test Procedure released by FCC on March 30, 2000 and ANSI C63.10-2013.

## 5 Summary of Test Results

Technical Requirements					
FCC Part 15 Subpart C/RSS-247 Issue 2/RSS-Gen Issue 5					
Test Condition			Pages	Test Result	Test Site
§15.207	RSS-GEN 8.8	Conducted emission AC power port	10	Pass	Site 1
§15.247(b)(1)	RSS-247 Clause 5.4(d)	Conducted peak output power	13	Pass	Site 1
§15.247(e)	RSS-247 Clause 5.2(b)	Power spectral density*	--	N/A	--
§15.247(a)(2)	RSS-247 Clause 5.2(a)	6dB bandwidth	--	N/A	--
§15.247(a)(1)	RSS-247 Clause 5.1(a) & RSS-Gen 6.7	20dB bandwidth and 99% Occupied Bandwidth	18	Pass	Site 1
§15.247(a)(1)	RSS-247 Clause 5.1(b)	Carrier frequency separation	25	Pass	Site 1
§15.247(a)(1)(iii)	RSS-247 Clause 5.1(d)	Number of hopping frequencies	28	Pass	Site 1
§15.247(a)(1)(iii)	RSS-247 Clause 5.1(d)	Dwell Time	30	Pass	Site 1
§15.247(d)	RSS-247 Clause 5.5	Spurious RF conducted emissions	33	Pass	Site 1
§15.247(d)	RSS-247 Clause 5.5	Band edge	37	Pass	Site 1
§15.247(d) & §15.209 & §15.205	RSS-247 Clause 5.5 & RSS-GEN 6.13 RSS-GEN 8.9 RSS-GEN 8.10	Spurious radiated emissions for transmitter and receiver	42	Pass	Site 1
§15.203	RSS-GEN 6.8	Antenna requirement	See note 1	Pass	--

Note 1: N/A=Not Applicable.

Note 2: The EUT uses a PIFA antenna, which gain is -0.68dBi. In accordance to §15.203, it is considered sufficiently to comply with the provisions of this section.

## 6 General Remarks

### Remarks

This submittal(s) (test report) is intended for FCC ID: 2AFHW-VTA75, IC: 9577A-VTA75 complies with Section 15.205, 15.209, 15.247 of the FCC Part 15, Subpart C, RSS-247 issue 2 and RSS-Gen issue 5 rules.

### SUMMARY:

All tests according to the regulations cited on page 5 were

n - Performed

o - **Not** Performed

The Equipment Under Test

n - **Fulfills** the general approval requirements.

o - **Does not** fulfill the general approval requirements.

Sample Received Date: July 22, 2018

Testing Start Date: July 22, 2018

Testing End Date: November 18, 2018

Reviewed by:



Phoebe Hu  
EMC Section Manager

Prepared by:



Mark Chen  
EMC Project Engineer

Tested by:

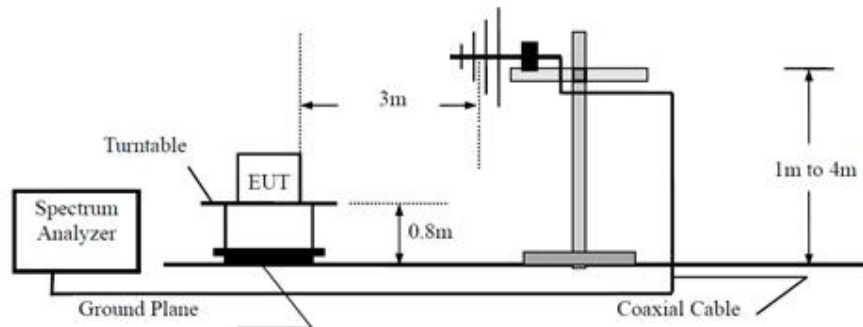


Tree Zhan  
EMC Test Engineer

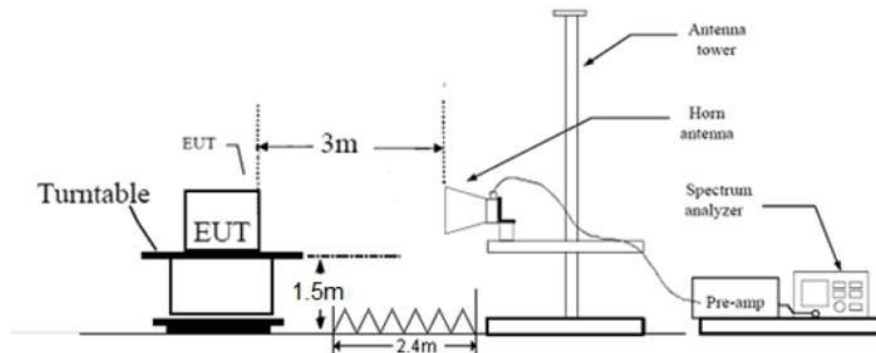
## 7 Test Setups

### 7.1 Radiated test setups

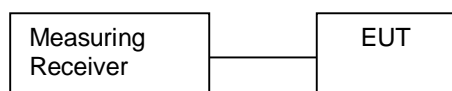
Below 1GHz



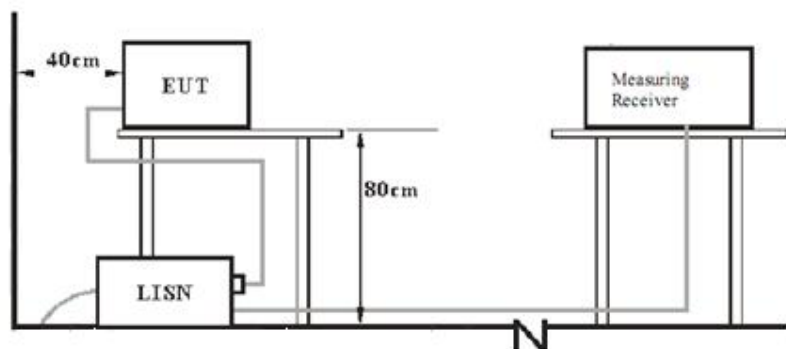
Above 1GHz



### 7.2 Conducted RF test setups



### 7.3 AC Power Line Conducted Emission test setups





## 8 Systems test configuration

Auxiliary Equipment Used during Test:

DESCRIPTION	MANUFACTURER	MODEL NO.	S/N
Notebook	Lenovo	X220	---

Test software: FCCAssist\_1.5 Test Tool, which used to control the EUT in continues transmitting mode

The system was configured to hopping mode and non-hopping mode.

Hopping mode: typical working mode (normal hopping status)

Non-hopping mode: The system was configured to operate at a signal channel transmitting. The test software allows the configuration and operation at the worst-case duty and the highest transmit power.

## 9 Technical Requirement

### 9.1 Conducted Emission

#### Test Method

1. The EUT was placed on a table, which is 0.8m above ground plane
2. The power line of the EUT is connected to the AC mains through a Artificial Mains Network (A.M.N.).
3. Maximum procedure was performed to ensure EUT compliance
4. A EMI test receiver is used to test the emissions from both sides of AC line

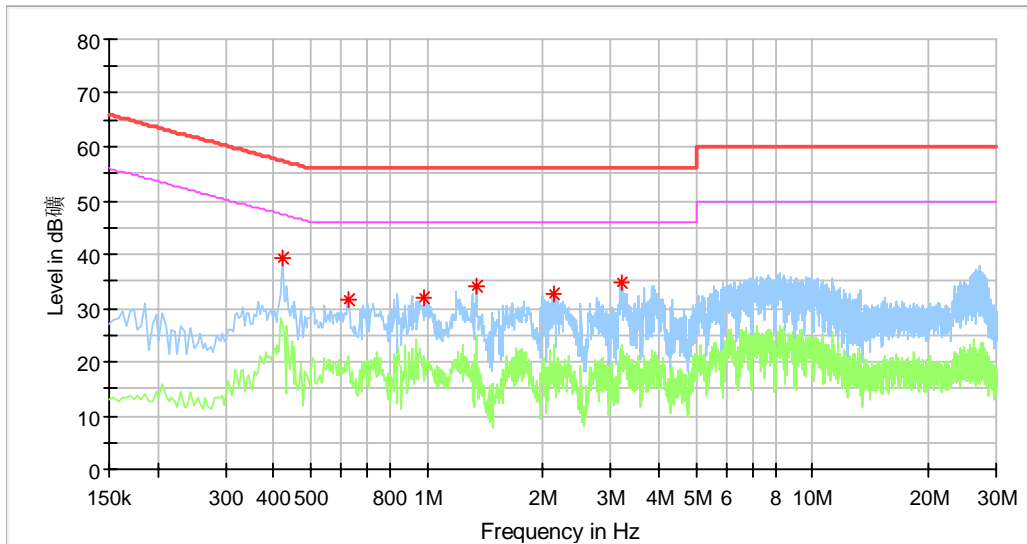
#### Limit

Frequency MHz	QP Limit dB $\mu$ V	AV Limit dB $\mu$ V
0.150-0.500	66-56*	56-46*
0.500-5	56	46
5-30	60	50

Decreasing linea

## Conducted Emission

Product Type : 5-in-1 Turntable  
 M/N : VTA-75  
 Operating Condition : BT Playing  
 Test Specification : Power Line, Live  
 Comment : AC 120V/60Hz



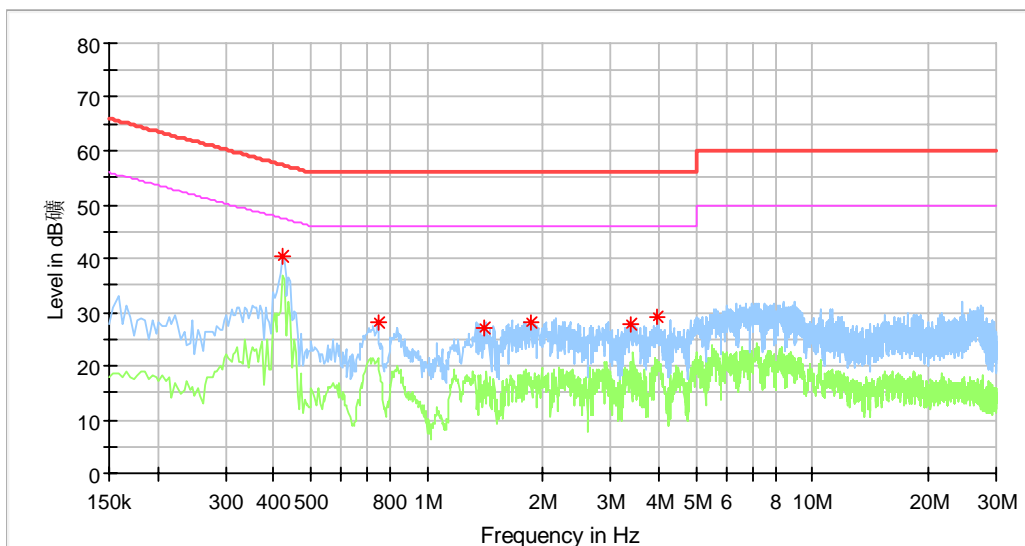
## Critical\_Freqs

Frequency (MHz)	MaxPeak (dBμV)	Average (dBμV)	Limit (dBμV)	Margin (dB)	Line	Corr. (dB)
0.422000	39.17	---	57.41	18.24	L1	10.3
0.626000	31.49	---	56.00	24.51	L1	10.3
0.982000	32.02	---	56.00	23.98	L1	10.3
1.342000	33.96	---	56.00	22.04	L1	10.3
2.134000	32.80	---	56.00	23.20	L1	10.3
3.190000	34.62	---	56.00	21.38	L1	10.4

Remark : “\*” Correct factor=cable loss + LISN factor

## Conducted Emission

Product Type : 5-in-1 Turntable  
 M/N : VTA-75  
 Operating Condition : BT Playing  
 Test Specification : Power Line, Neutral  
 Comment : AC 120V/60Hz



## Critical\_Freqs

Frequency (MHz)	MaxPeak (dBµV)	Average (dBµV)	Limit (dBµV)	Margin (dB)	Line	Corr. (dB)
0.422000	40.23	---	57.41	17.17	N	10.3
0.746000	28.15	---	56.00	27.85	N	10.3
1.406000	27.00	---	56.00	29.00	N	10.3
1.854000	28.03	---	56.00	27.97	N	10.3
3.378000	27.69	---	56.00	28.31	N	10.4
3.974000	29.06	---	56.00	26.94	N	10.4

Remark : “\*” Correct factor=cable loss + LISN factor

## 9.2 Conducted peak output power

### Test Method

1. Use the following spectrum analyzer settings:  
Span = approximately 5 times the 20dB bandwidth, centered on a hopping channel  
RBW > the 20dB bandwidth of the emission being measured, VBW ≥ RBW,  
Sweep = auto, Detector function = peak, Trace = max hold
2. Add a correction factor to the display.
3. Allow the trace to stabilize. Use the marker-to-peak function to set the marker to the peak of the emission. The indicated level is the peak output power

### Limits

Frequency Range MHz	Limit W	Limit dBm
2400-2483.5	≤1	≤30

### For e.i.r.p

Frequency Range MHz	Limit W	Limit dBm
2400-2483.5	≤4	≤36

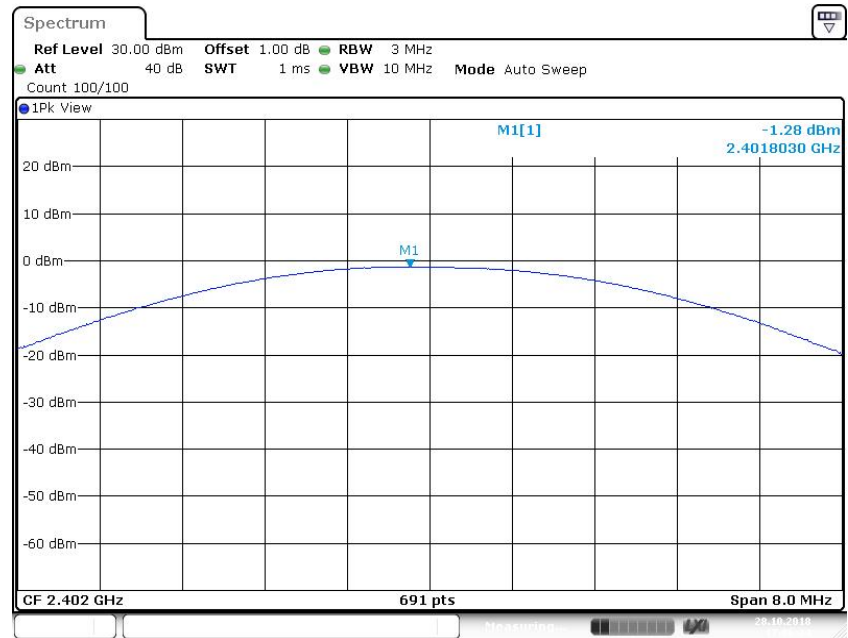


Conducted peak output power

Bluetooth Mode GFSK modulation Test Result

Frequency MHz	Conducted Peak Output Power dBm	E.I.R.P dBm	Result
Low channel 2402MHz	-1.28	-1.96	Pass
Middle channel 2441MHz	-0.54	-1.22	Pass
High channel 2480MHz	0.33	-0.35	Pass

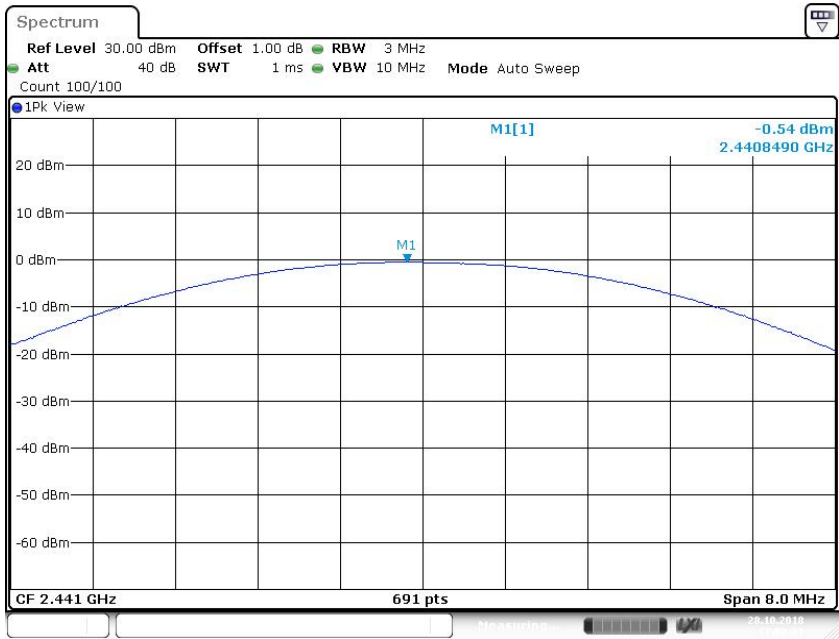
Low channel 2402MHz



Date: 28 OCT 2018 17:06:24

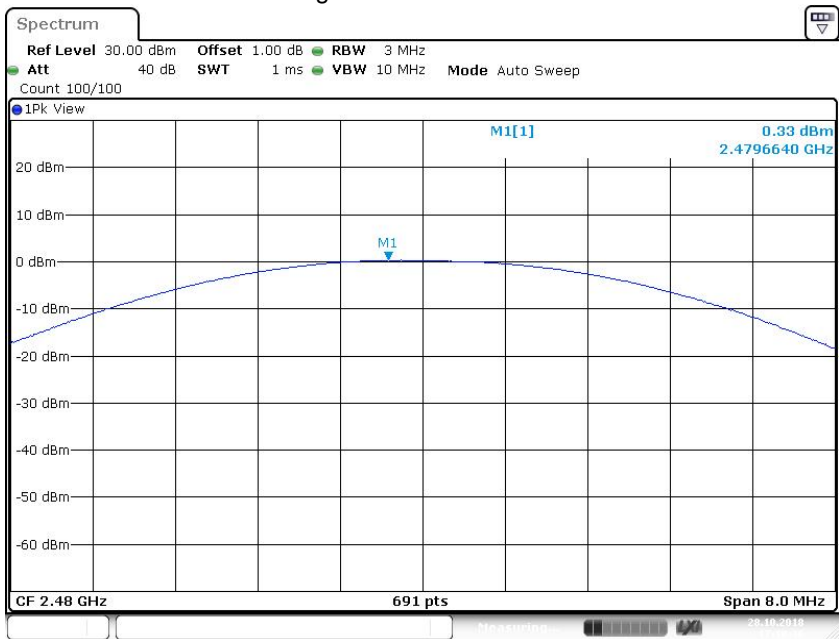


Middle channel 2441MHz



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High channel 2480MHz



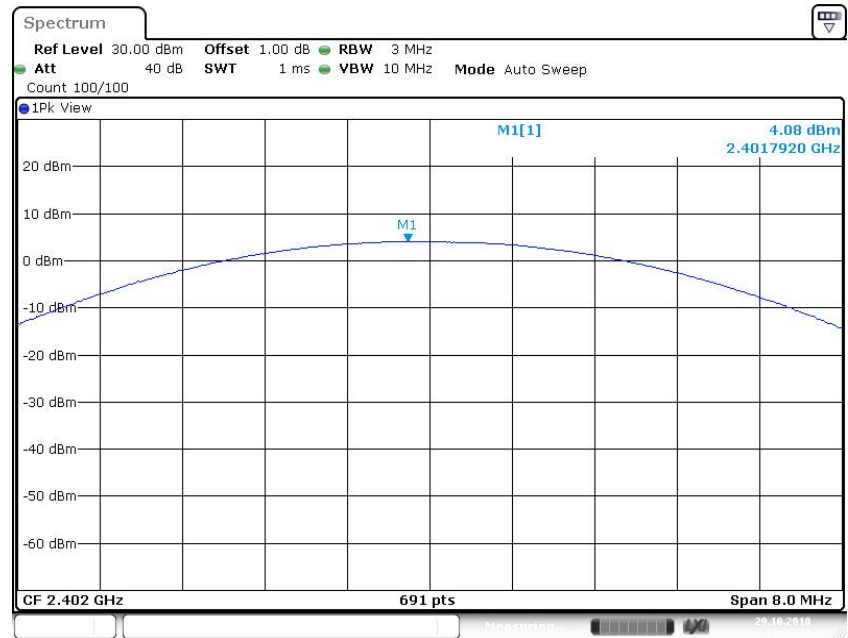
Date: 28 OCT 2018 17:10:36



Bluetooth Mode  $\pi/4$ -DQPSK modulation Test Result

Frequency MHz	Conducted Peak Output		Result
	Power dBm	E.I.R.P dBm	
Low channel 2402MHz	4.08	3.40	Pass
Middle channel 2441MHz	2.20	1.52	Pass
High channel 2480MHz	1.14	0.46	Pass

Low channel 2402MHz

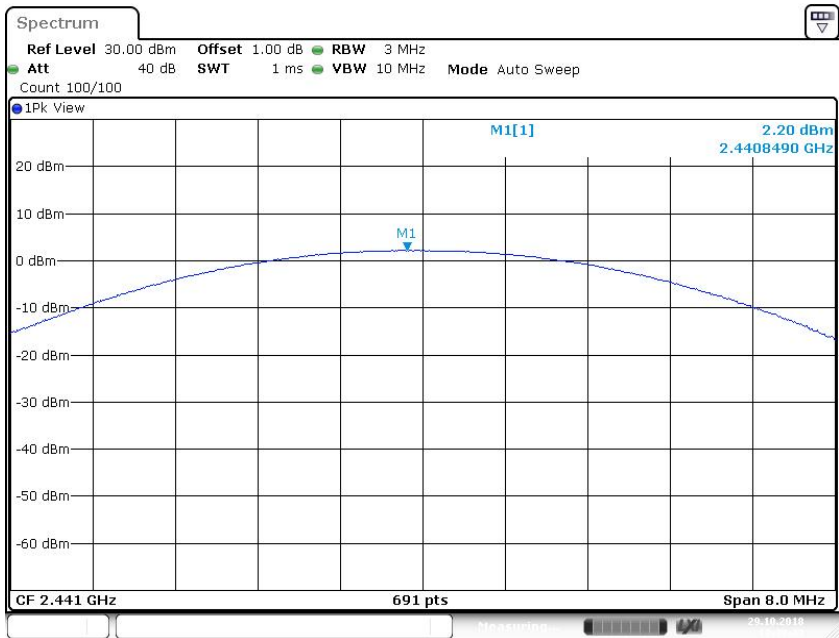


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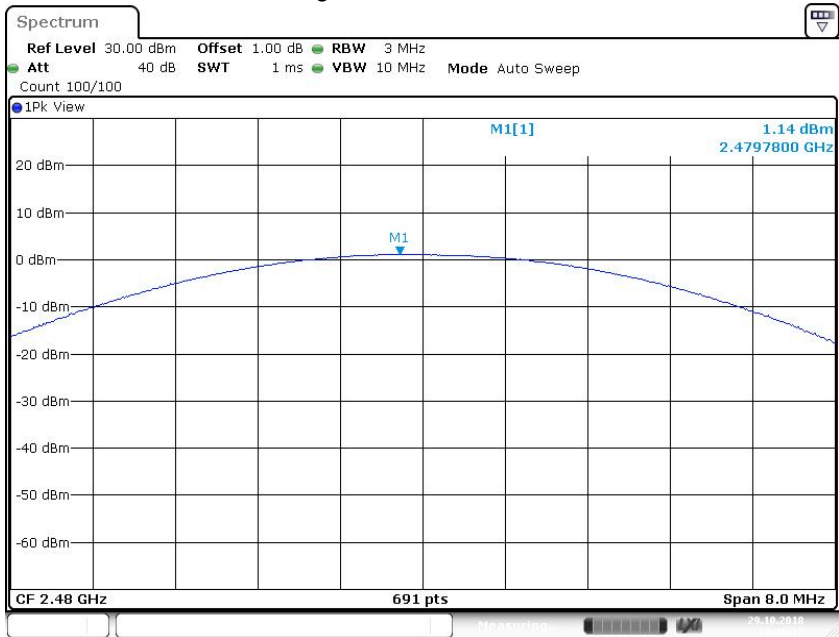


Middle channel 2441MHz



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High channel 2480MHz



Date: 29 OCT 2018 13:46:17

### 9.3 20 dB bandwidth and 99% Occupied Bandwidth

#### Test Method

1. Check the calibration of the measuring instrument using either an internal calibrator or a known signal from an external generator.
2. Position the EUT without connection to measurement instrument. Turn on the EUT and connect it to measurement instrument. Then set it to any one convenient frequency within its operating range. Set a reference level on the measuring instrument equal to the highest peak value.
3. Measure the frequency difference of two frequencies that were attenuated 20 dB from the reference level. Record the frequency difference as the emission bandwidth.
4. Repeat above procedures until all frequencies measured were complete.

#### Limit

Limit [kHz]

---

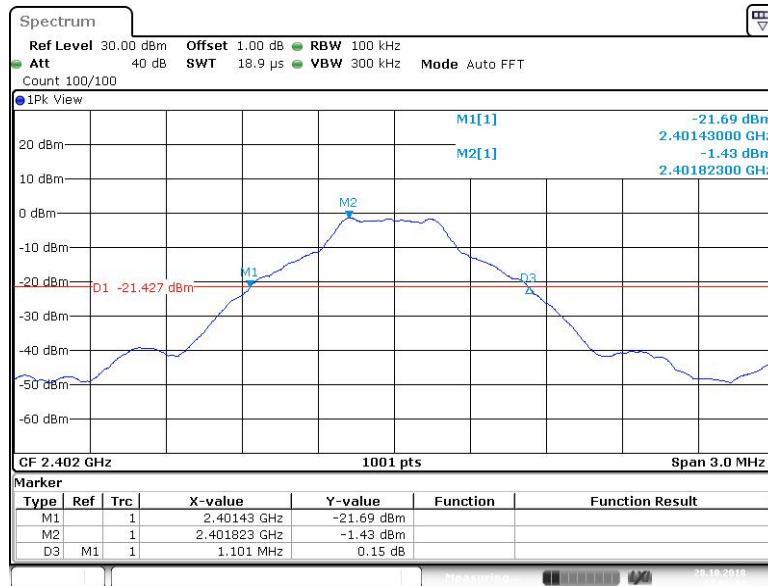
N/A

## 20 dB bandwidth and 99% Occupied Bandwidth

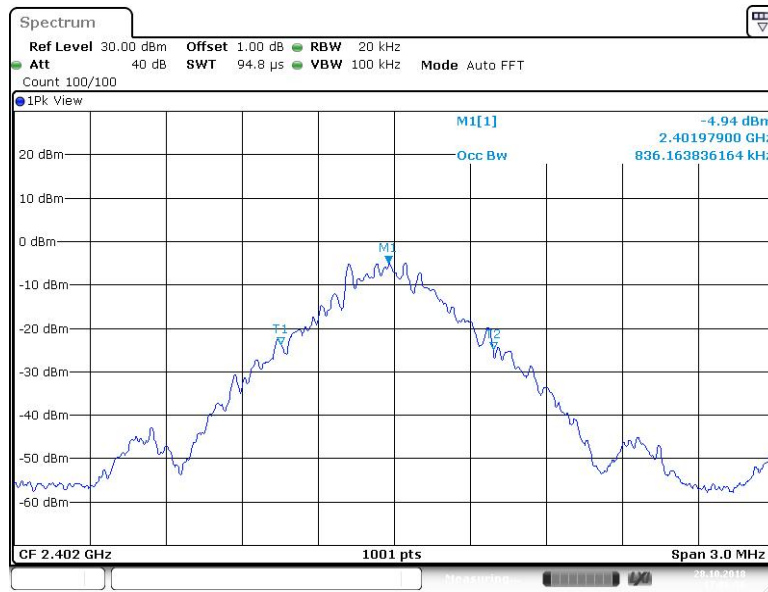
### Bluetooth Mode GFSK Modulation test result

Frequency MHz	20 dB Bandwidth kHz	99% Bandwidth kHz	Limit kHz	Result
2402	1101	836	--	Pass
2441	1104	857	--	Pass
2480	1107	854	--	Pass

Low channel 2402MHz



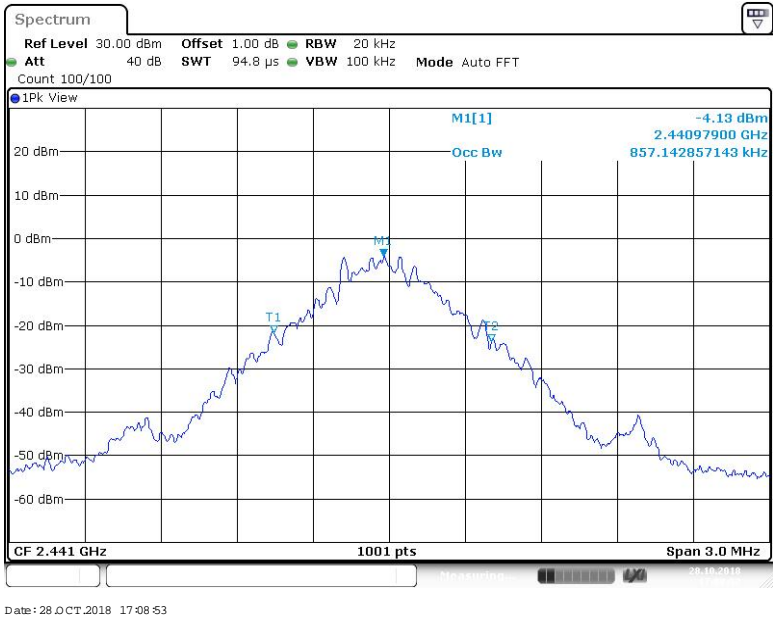
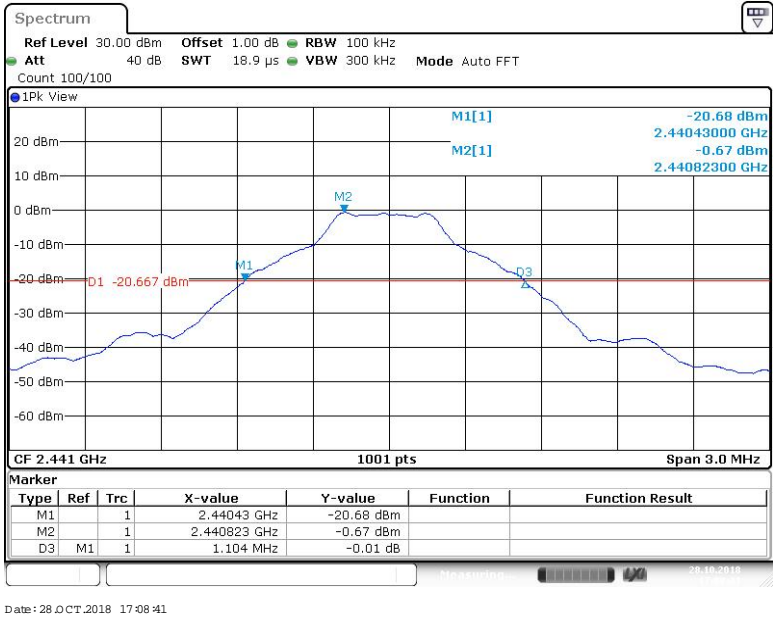
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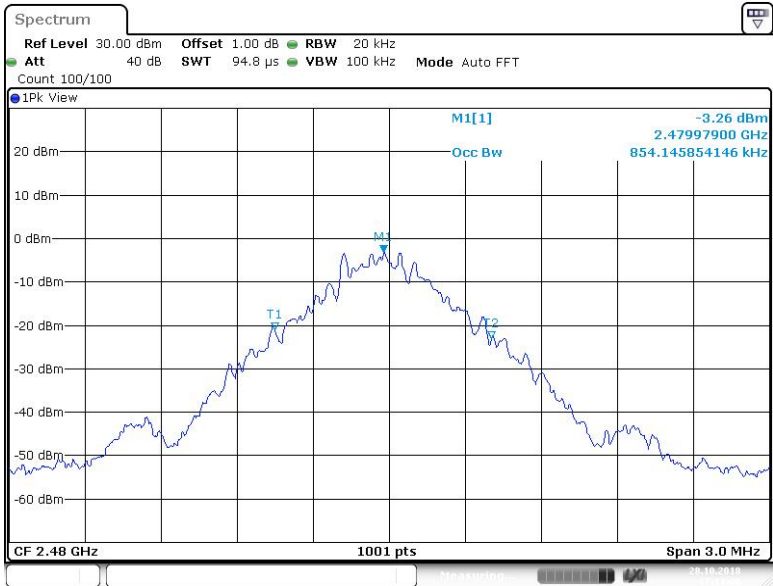
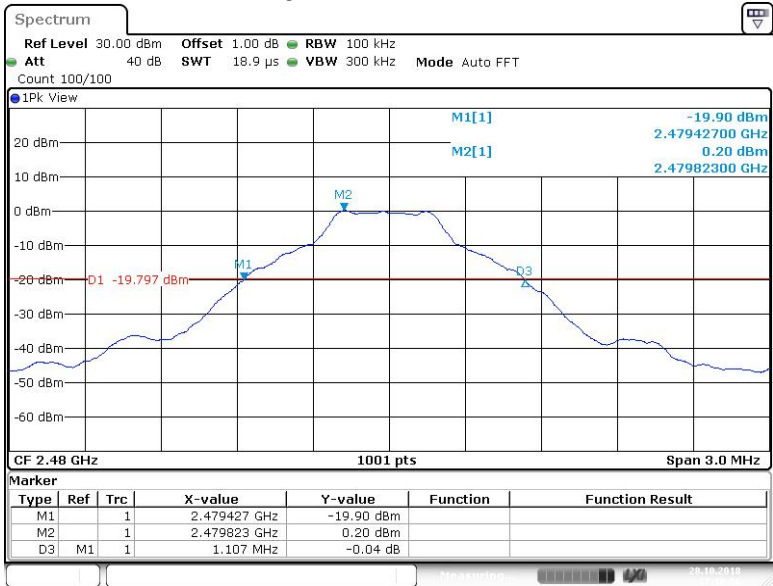


Middle channel 2441MHz





High channel 2480MHz



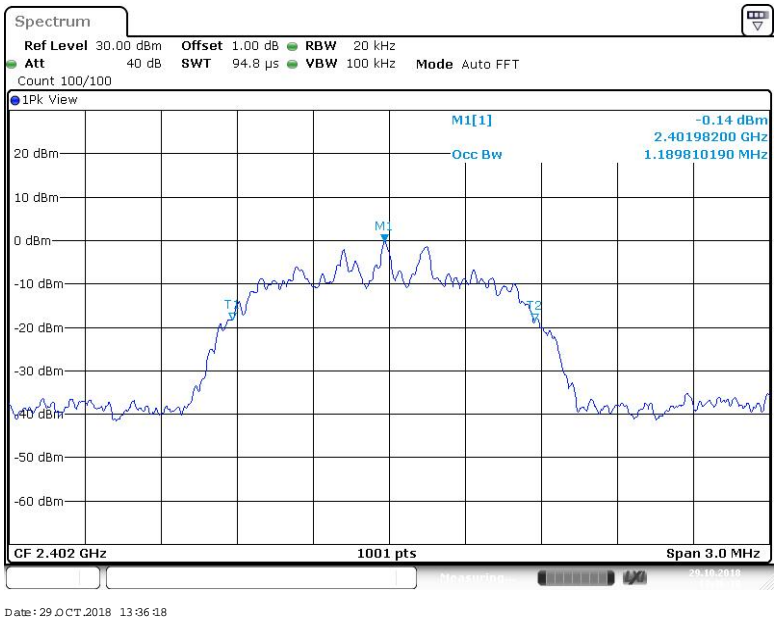
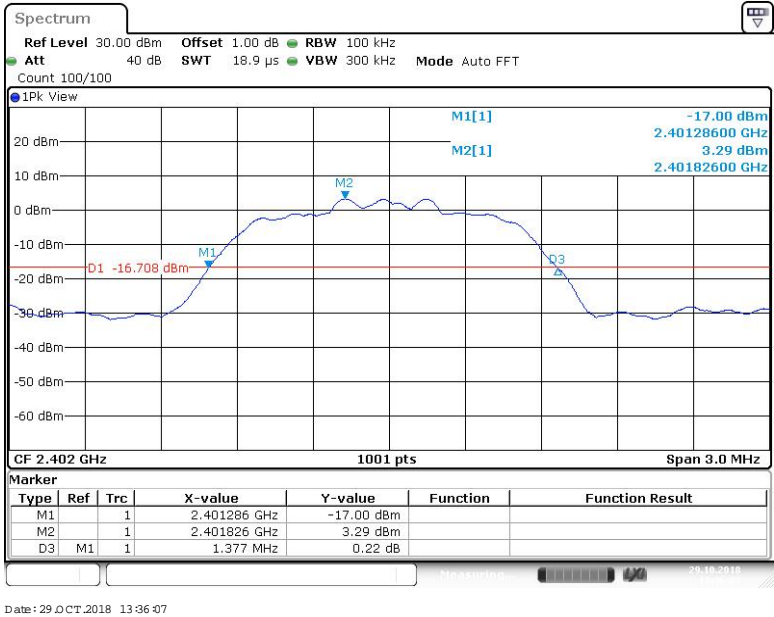


20 dB bandwidth and 99% Occupied Bandwidth

Bluetooth Mode  $\pi/4$ -DQPSK Modulation test result

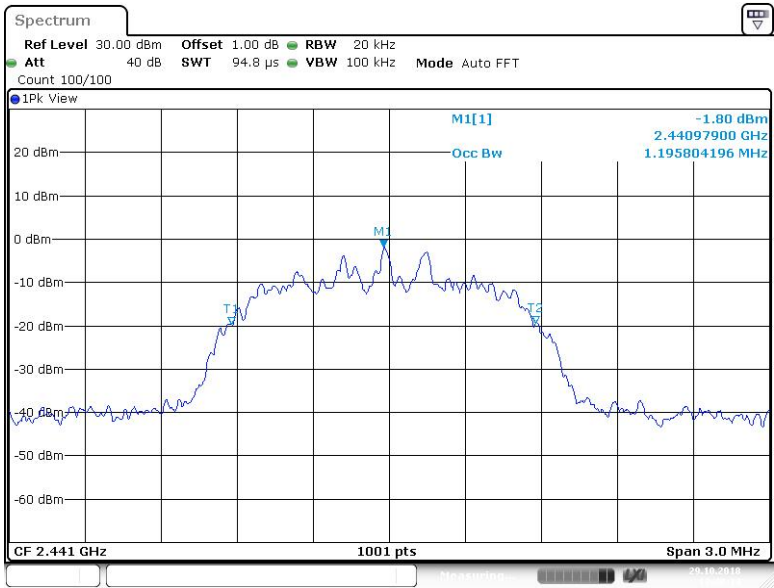
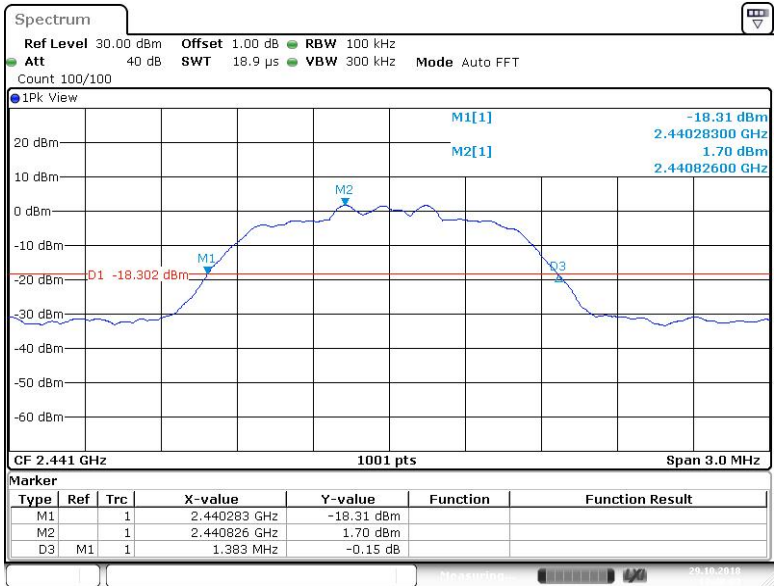
Frequency	20 dB Bandwidth	99% Bandwidth	Limit	Result
MHz	kHz	kHz	kHz	
2402	1377	1190	--	Pass
2441	1383	1196	--	Pass
2480	1383	1193	--	Pass

Low channel 2402MHz



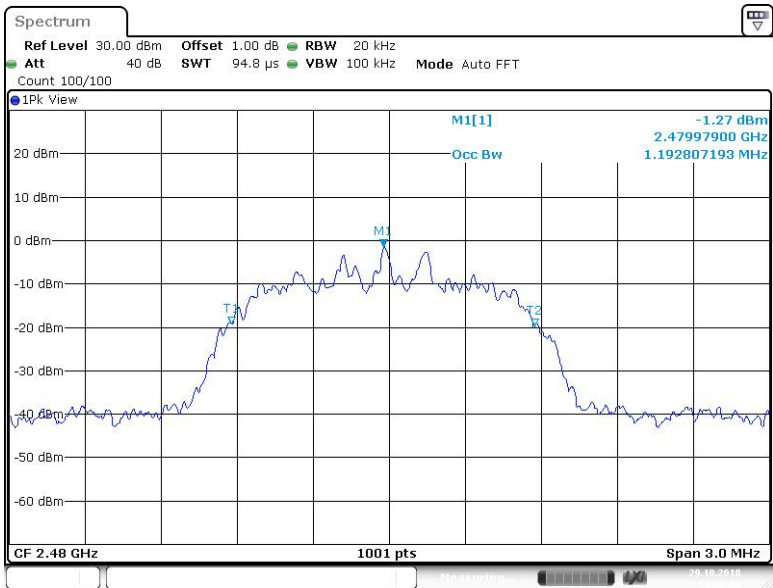
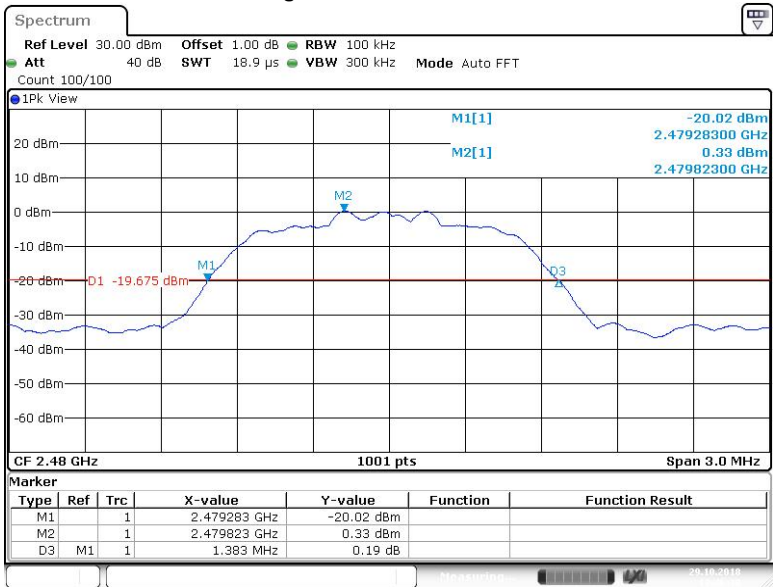


Middle channel 2441MHz





High channel 2480MHz





## 9.4 Carrier Frequency Separation

### Test Method

1. Use the following spectrum analyzer settings:  
Span = wide enough to capture the peaks of two adjacent channels, RBW  $\geq$  1% of the span, VBW  $\geq$  RBW, Sweep = auto, Detector function = peak
2. By using the Max-Hold function record the separation of two adjacent channels.
3. Measure the frequency difference of these two adjacent channels by spectrum analyzer marker function.
4. Repeat above procedures until all frequencies measured were complete.

### Limit

Limit kHz
$\geq 25\text{kHz}$ or $2/3$ of the 20 dB bandwidth which is greater

### GFSK Modulation Limit

Frequency MHz	2/3 of 20 dB Bandwidth kHz
2402	--
2441	736
2480	--

### $\pi/4$ -DQPSK Modulation Limit

Frequency MHz	2/3 of 20 dB Bandwidth kHz
2402	--
2441	922
2480	--

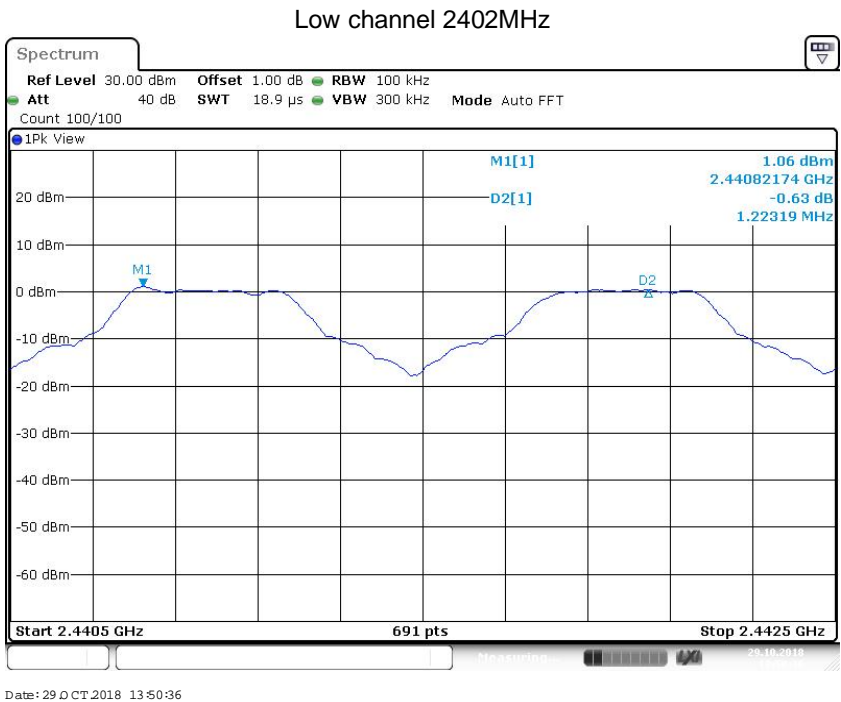


Carrier Frequency Separation

Test result: The measurement was performed with the typical configuration (normal hopping status), here GFSK modulation mode was used to show compliance.

GFSK Modulation test result

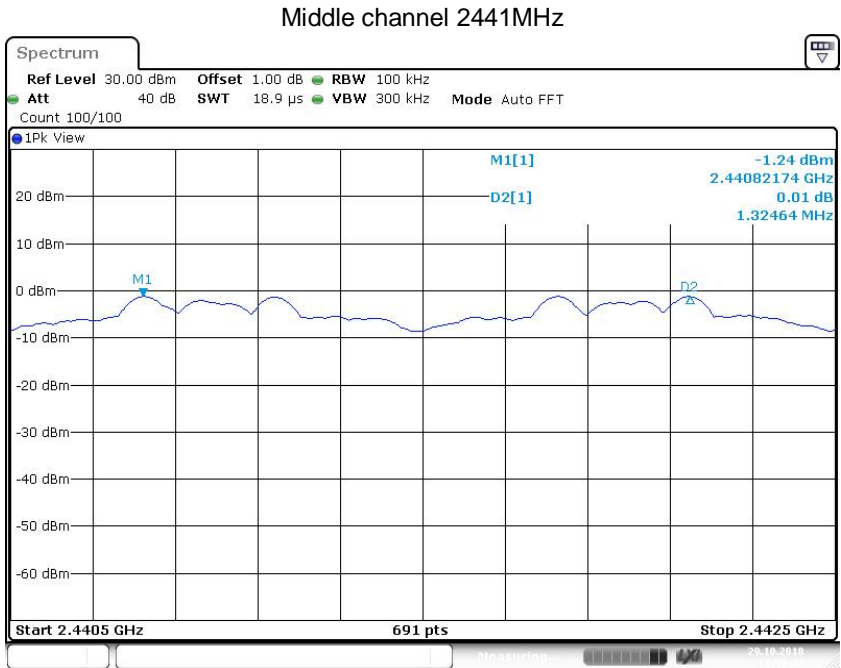
Frequency MHz	Carrier Frequency Separation kHz	Result
2402	--	Pass
2441	1223	Pass
2480	--	Pass





π/4-DQPSK Modulation test result

Frequency MHz	Carrier Frequency Separation kHz	Result
2402	--	Pass
2441	1325	Pass
2480	--	Pass



Date: 29 OCT 2018 13:58:42

## 9.5 Number of hopping frequencies

### Test Method

1. Use the following spectrum analyzer settings:  
Span = wide enough to capture the peaks of two adjacent channels,  $RBW \geq 1\%$  of the span,  $VBW \geq RBW$ , Sweep = auto, Detector function = peak
2. Set the spectrum analyzer on Max-Hold Mode, and then keep the EUT in hopping mode.
3. Record all the signals from each channel until each one has been recorded.
4. Repeat above procedures until all frequencies measured were complete.

### Limit

Limit  
number

---

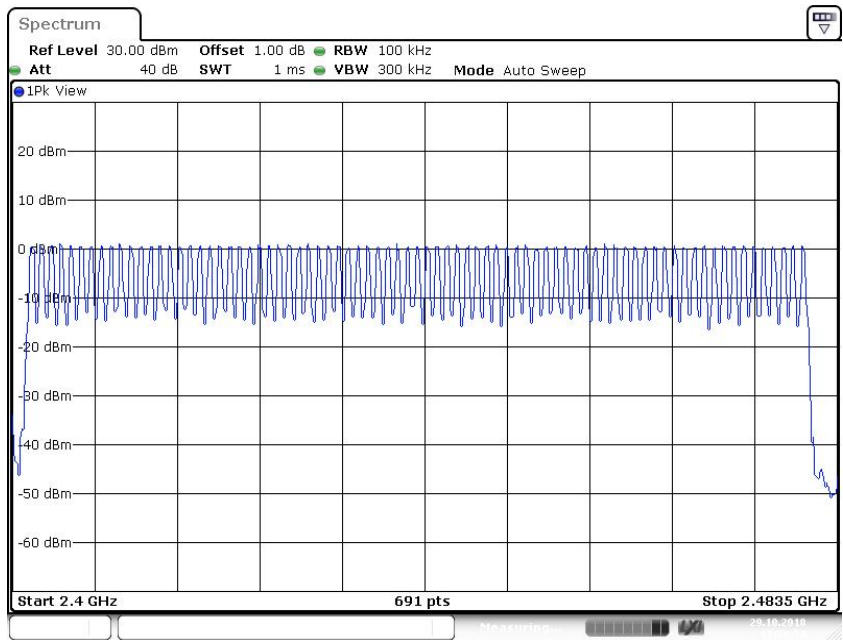
$\geq 15$



Number of hopping frequencies

Test result: The measurement was performed with the typical configuration (normal hopping status), and the total hopping channels is constant for the all modulation mode according with the Bluetooth Core Specification. Here GFSK modulation mode was used to show compliance.

Number of hopping frequencies	Result
79	Pass



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## 9.6 Dwell Time

### Test Method

1. Connect EUT antenna terminal to the spectrum analyzer with a low loss cable.  
Equipment mode: Spectrum analyzer
2. RBW: 1MHz; VBW: 1MHz; SPAN: Zero Span
3. Adjust the center frequency of spectrum analyzer on any frequency be measured.
4. Measure the Dwell Time by spectrum analyzer Marker function.
5. Repeat above procedures until all frequencies measured were complete.

### Limit

The average time of occupancy on any frequency shall not be greater than 0.4 seconds within a period of 0.4 seconds multiplied by the number of hopping channels employed.



Dwell Time

Dwell time

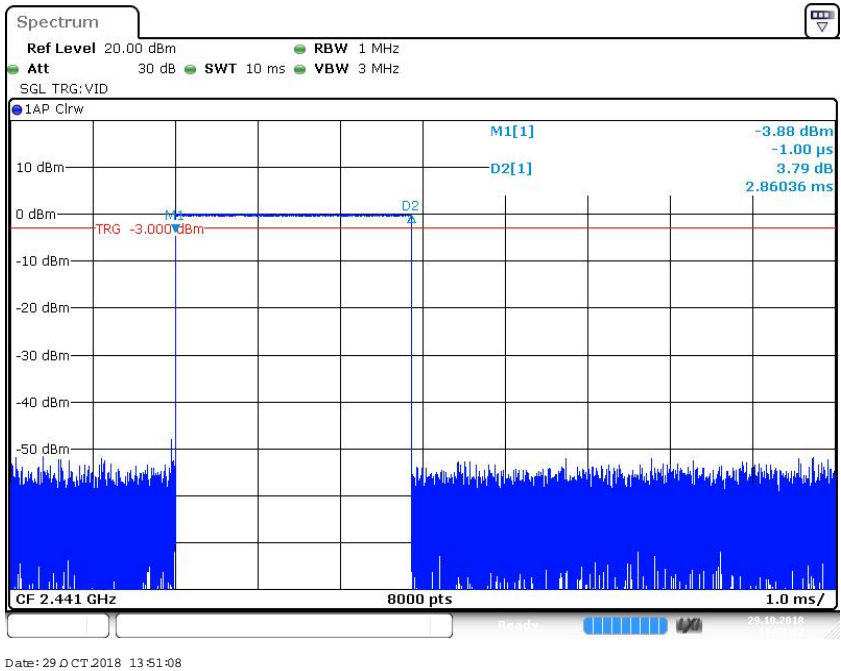
The maximum dwell time shall be 0.4 s.  
According to the Bluetooth Core Specification, the worse result (DH5 mode) was reported to show compliance.

The Dwell Time = Burst Width \* Total Hops. The detailed calculations are showed as follows:  
The duration for dwell time calculation: 0.4 [s] \* hopping number = 0.4 [s] \* 79 [ch] = 31.6 [s\*ch];  
The burst width, which is directly measured, refers to the duration on one channel hop.  
The maximum number of hopping channels in 31.6s for DH5=1600 / 6 / 79 \*31.6=106.67

Test Result

Modulation	Mode	Reading (us)	Total Hops	Test Result (ms)	Limit (ms)	Result
GFSK	DH5	2860	106.67	305.08	< 400	Pass
π/4-DQPSK	2DH5	2870	106.67	306.14	< 400	Pass

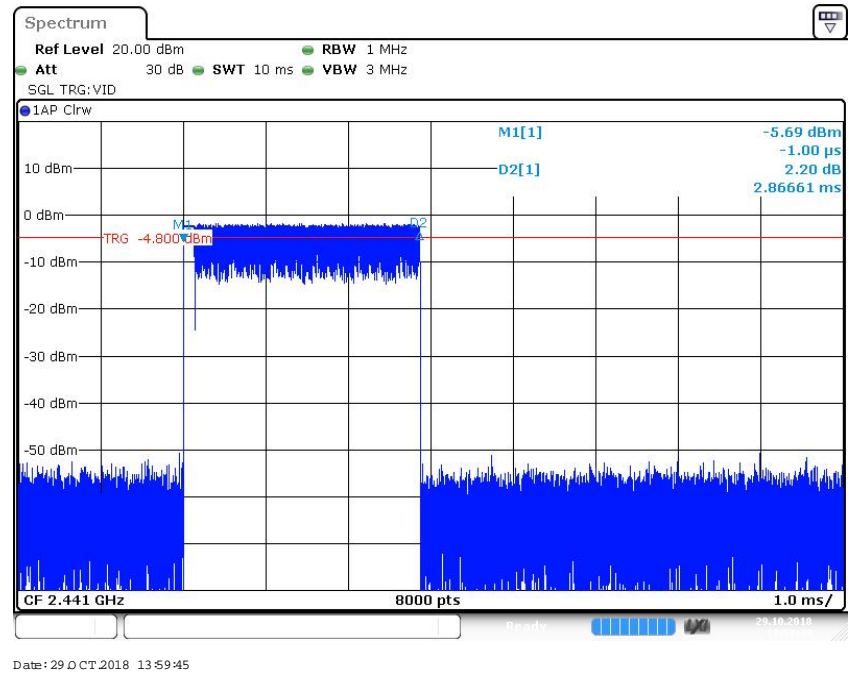
GFSK Modulation



DH5



$\pi/4$ -DQPSK Modulation



2DH5



## 9.7 Spurious RF conducted emissions

### Test Method

1. Use the following spectrum analyzer settings:  
Span = wide enough to capture the peak level of the in-band emission and all spurious emissions (e.g., harmonics) from the lowest frequency generated in the EUT up through the 10<sup>th</sup> harmonic. Typically, several plots are required to cover this entire span.  
RBW = 100 kHz, VBW ≥ RBW, Sweep = auto, Detector function = peak, Trace = max hold
2. Allow the trace to stabilize. Set the marker on the peak of any spurious emission recorded.
3. The level displayed must comply with the limit specified in this Section. Submit these plots.
4. Repeat above procedures until all frequencies measured were complete.

### Limit

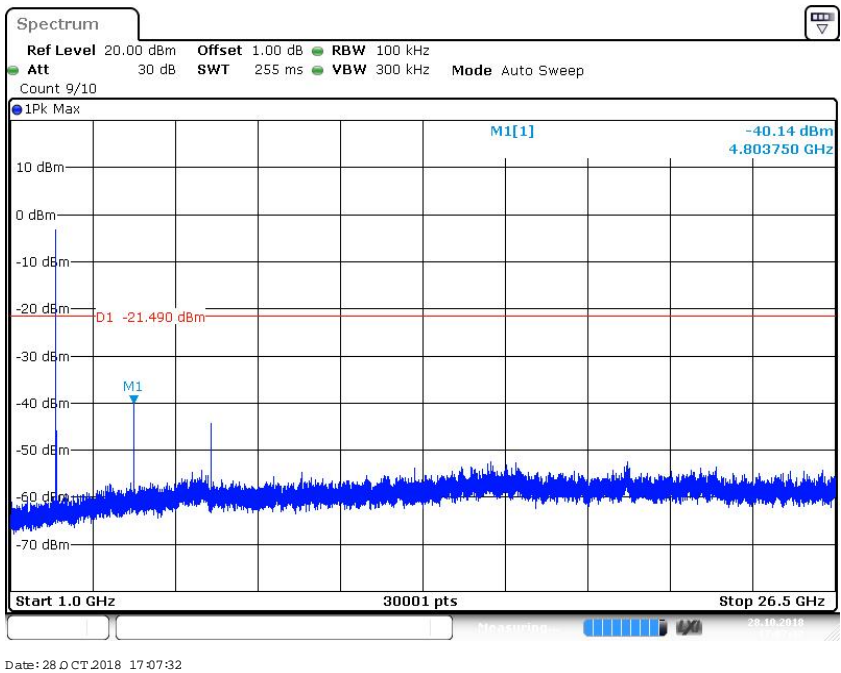
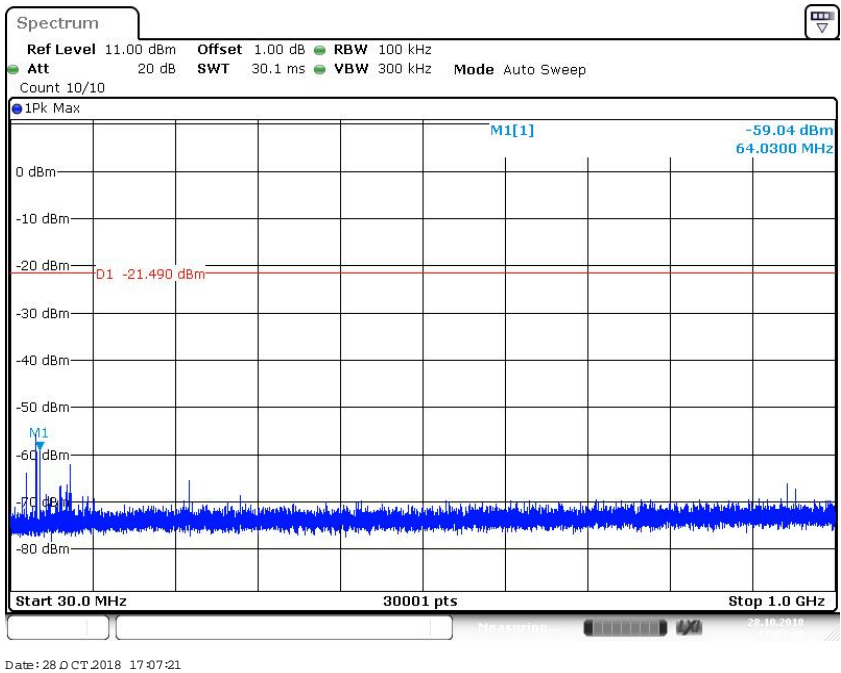
Frequency Range MHz	Limit (dBc)
30-25000	-20



Spurious RF conducted emissions

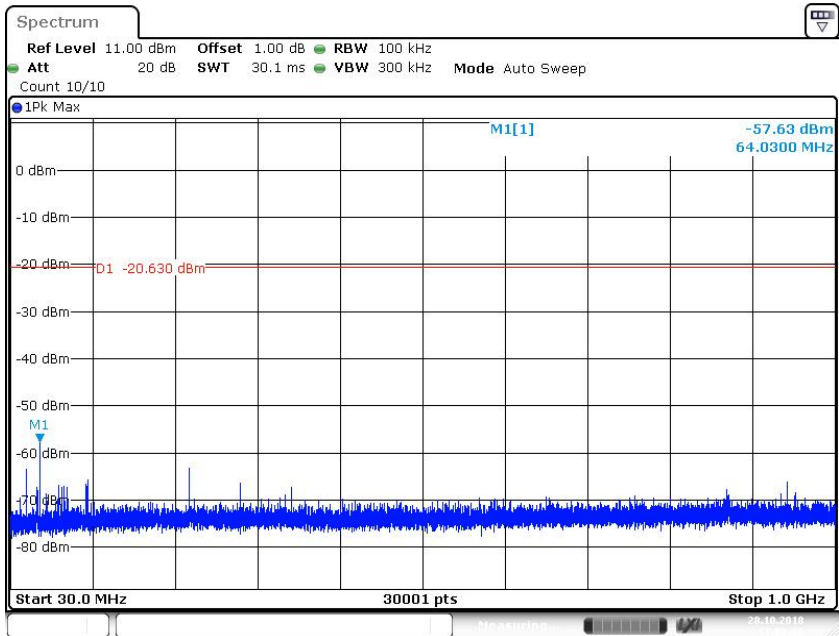
Only the worse case (which is subject to the maximum EIRP, GFSK mode) test result is listed in the report.  
GFSK Modulation:

Low channel 2402MHz

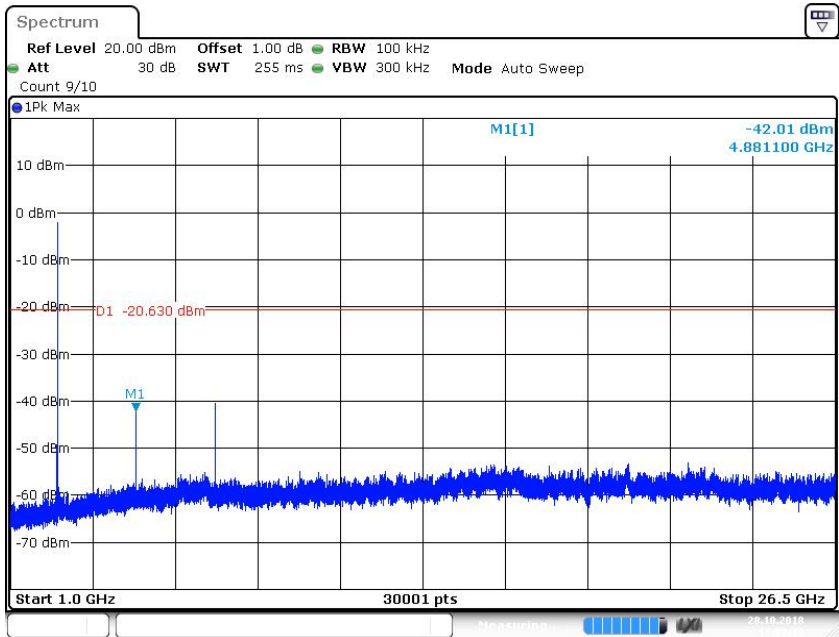




Middle channel 2441MHz



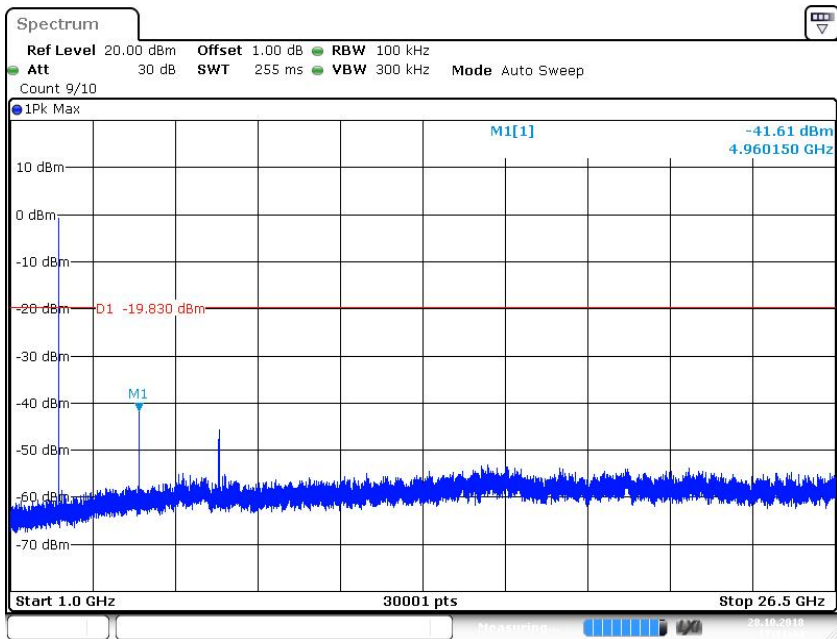
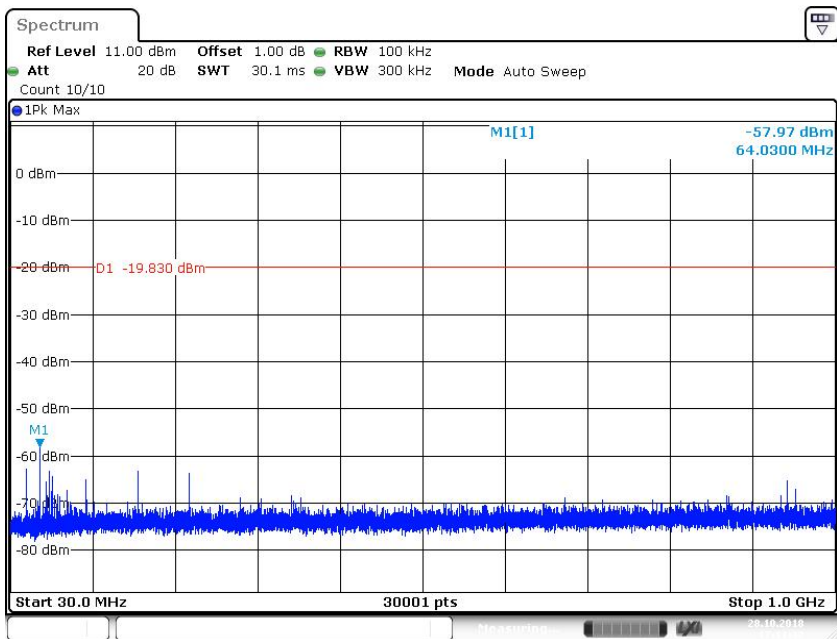
Date: 28 OCT 2018 17:09:07



Date: 28 OCT 2018 17:09:19



High channel 2480MHz



## 9.8 Band edge testing

### Test Method

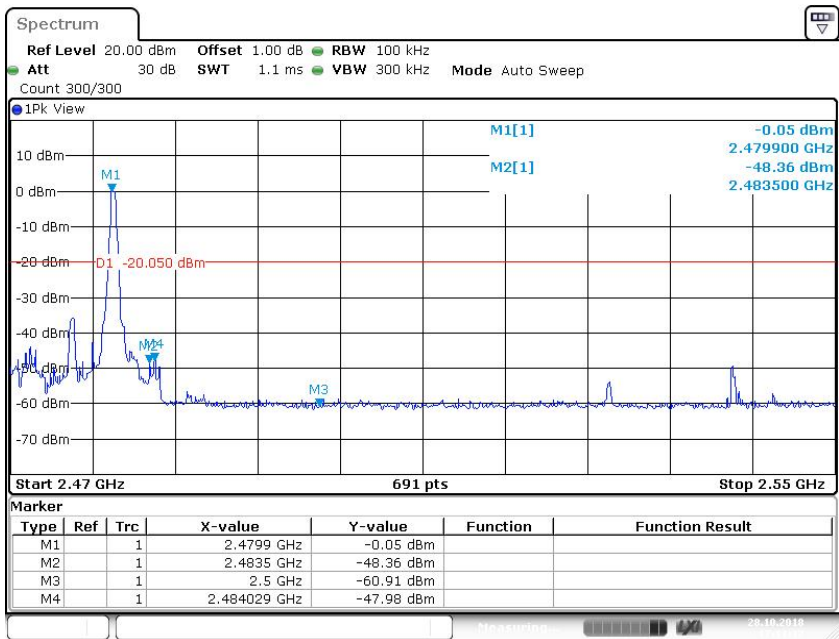
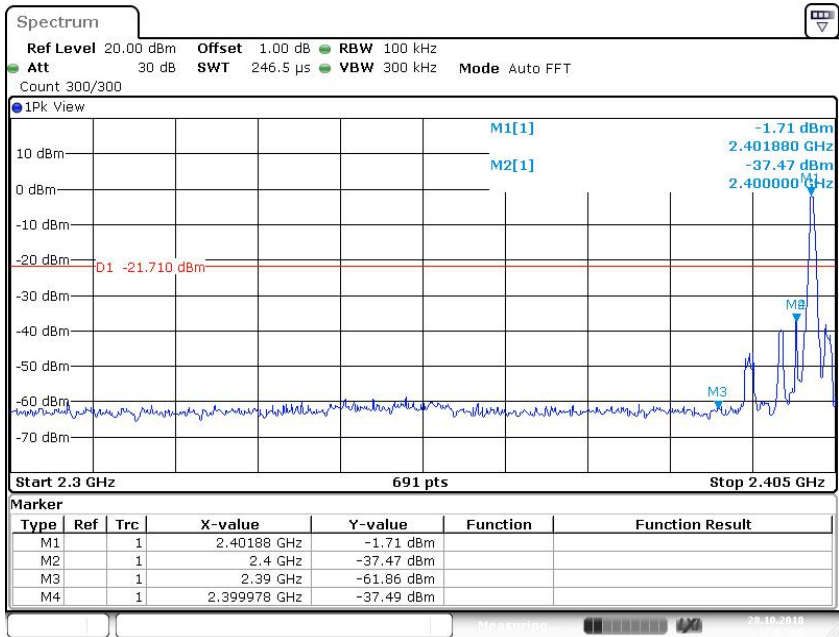
- 1 Use the following spectrum analyzer settings:  
Span = wide enough to capture the peak level of the in-band emission and all spurious  
RBW = 100 kHz, VBW  $\geq$  RBW, Sweep = auto, Detector function = peak, Trace = max hold
- 2 Allow the trace to stabilize, use the peak and delta measurement to record the result.
- 3 The level displayed must comply with the limit specified in this Section. .
- 4 Repeat the test at the hopping off and hopping on mode, submit all the plots.

### Limit:

In any 100 kHz bandwidth outside the frequency band in which the spread spectrum or digitally modulated device is operating, the RF power that is produced shall be at least 20 dB below that in the 100 kHz bandwidth within the band that contains the highest level of the desired power, based on either an RF conducted or a radiated measurement, provided that the transmitter demonstrates compliance with the peak conducted power limits.

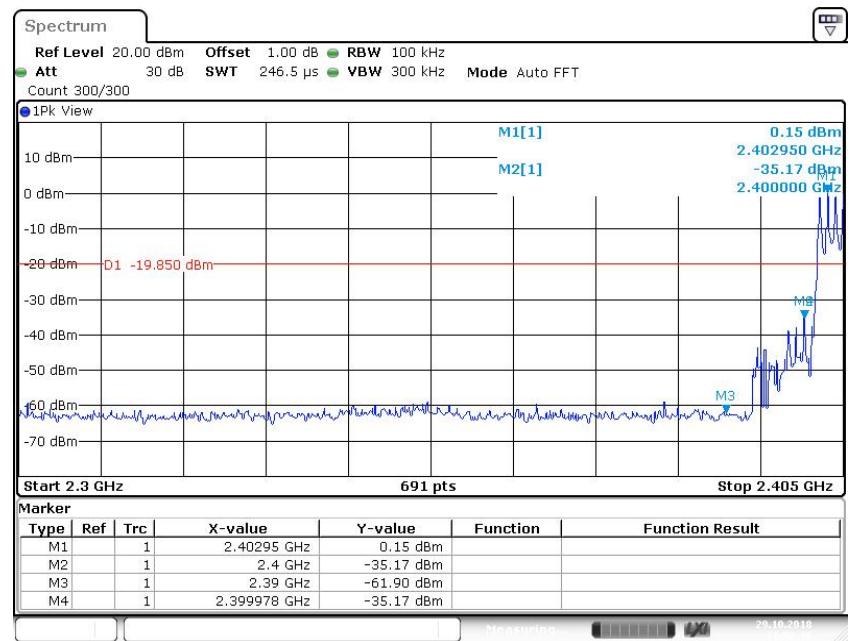


GFSK mode: Hopping off

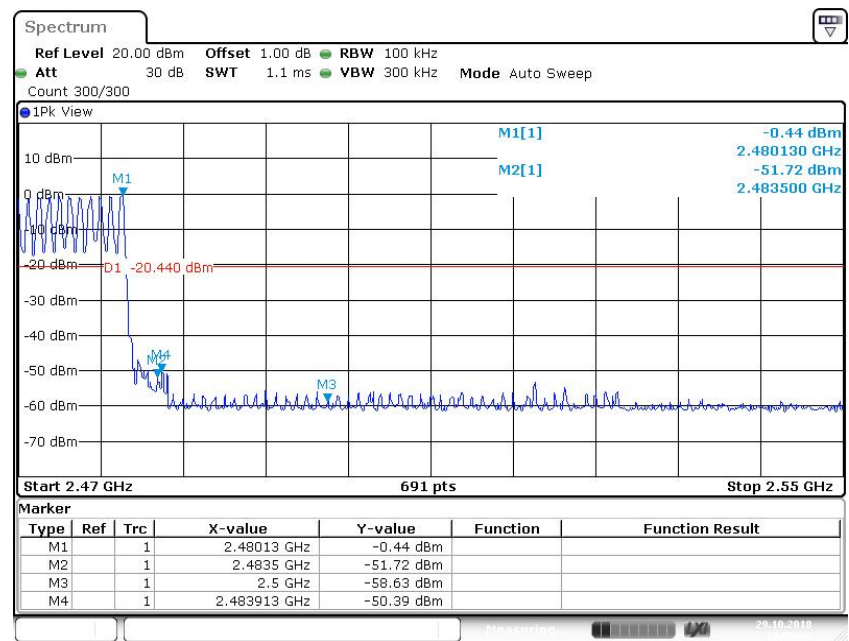




GFSK mode: Hopping on



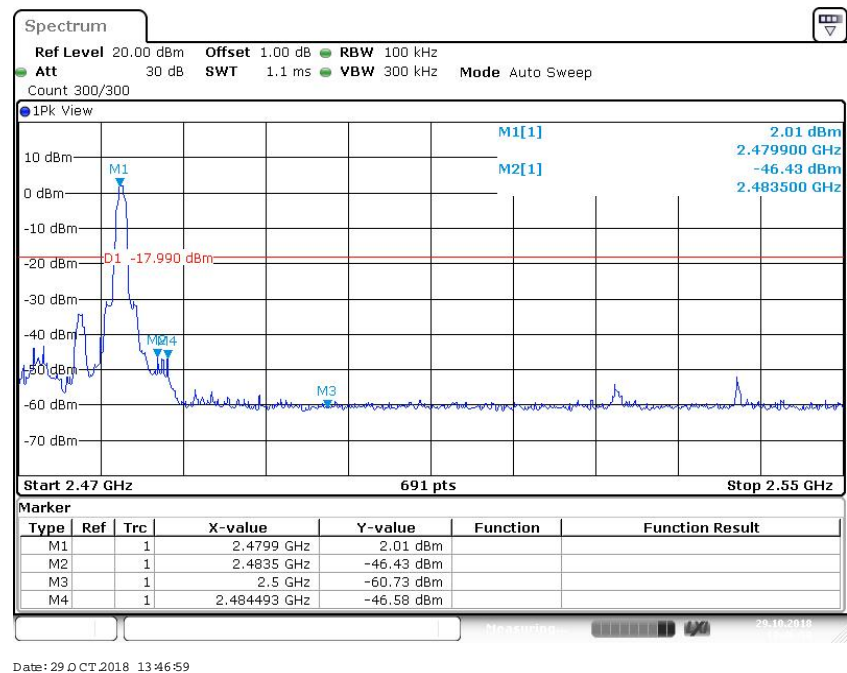
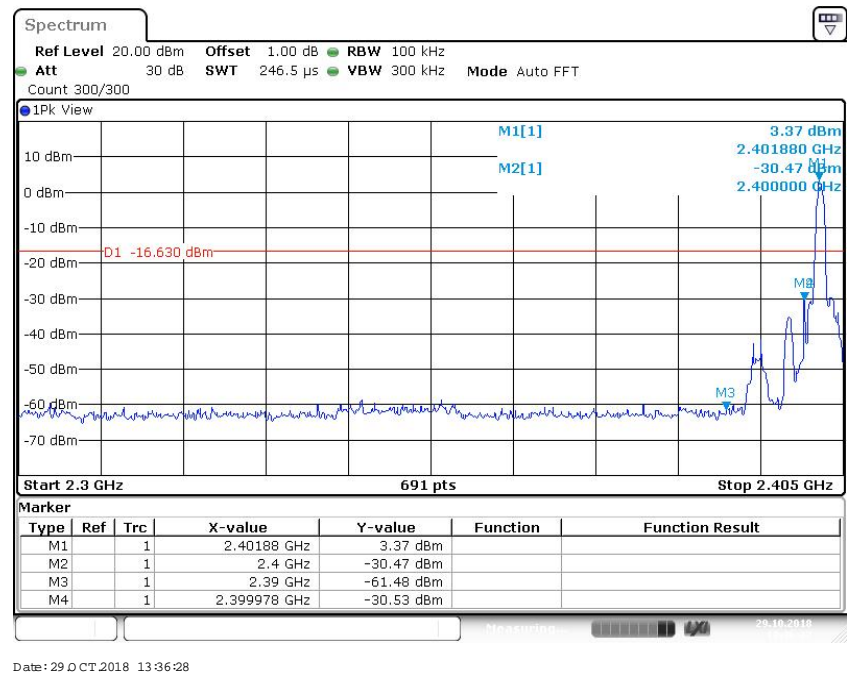
Date: 29 OCT 2018 13:50:15



Date: 29 OCT 2018 13:55:22



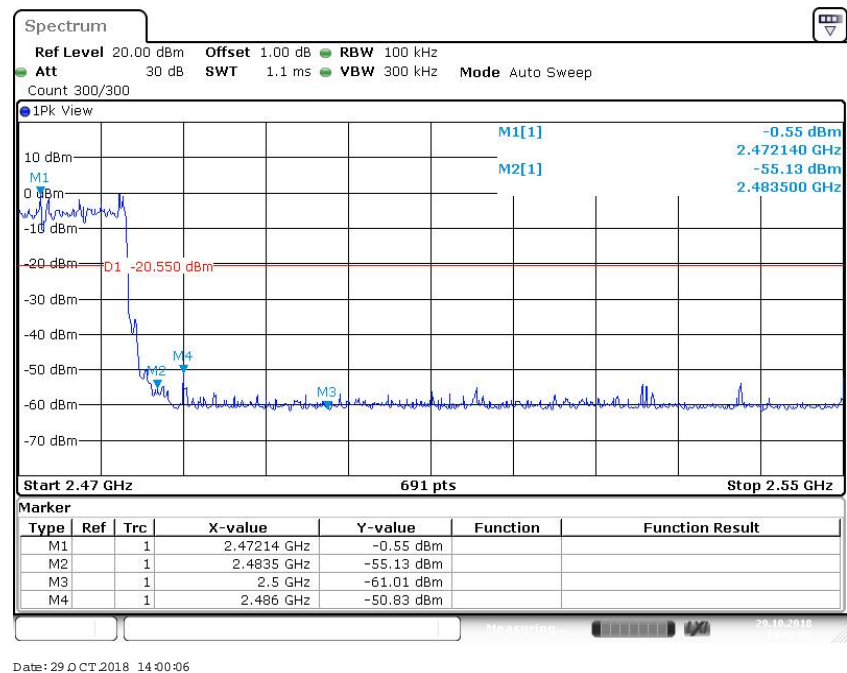
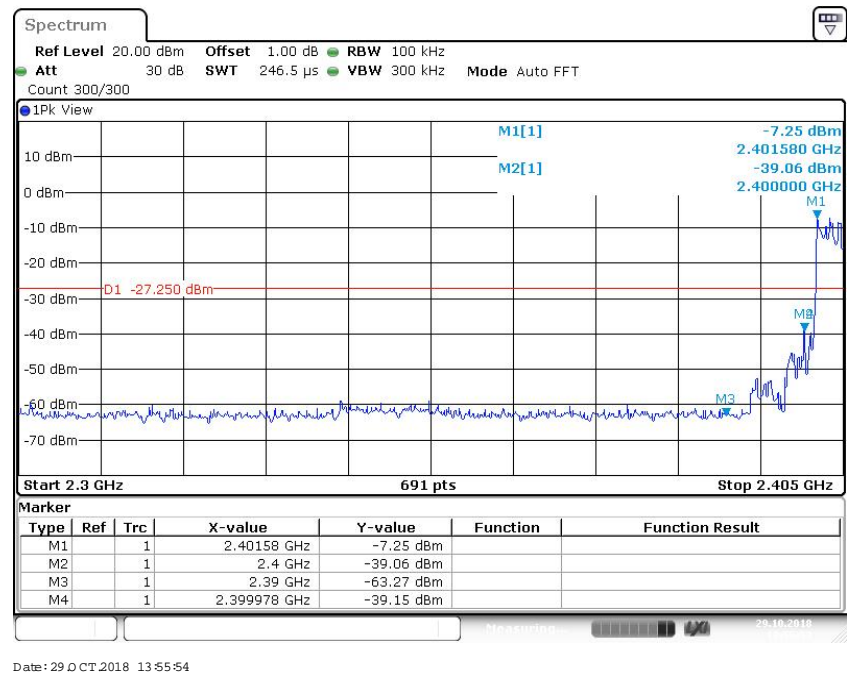
$\pi/4$ -DQPSK mode: Hopping off







$\pi/4$ -DQPSK mode: Hopping on



## 9.9 Spurious radiated emissions for transmitter

### Test Method

- 1: The EUT was placed on a turn table which is 1.5m above ground plane for above 1GHz and 0.8m above ground for below 1GHz at 3 meter chamber room for test. The table was rotated 360 degrees to determine the position of the highest radiation.
- 2: The EUT was set 3 meters away from the interference – receiving antenna, which was mounted on the top of a variable – height antenna tower.
- 3: The height of antenna is varied from one meter to four meters above the ground to determine the maximum value of the field strength. Both horizontal and vertical polarizations of the antenna are set to make the measurement.
- 4: For each suspected emission, the EUT was arranged to its worst case and then the antenna was tuned to heights from 1 meter to 4 meters and the rotatable table was turned from 0 degrees to 360 degrees to find the maximum reading.
- 5: Use the following spectrum analyzer settings According to C63.10:

For Above 1GHz

Span = wide enough to capture the peak level of the in-band emission and all spurious  
RBW = 1MHz, VBW  $\geq$  RBW for peak measurement and VBW = 10Hz for average measurement, Sweep = auto, Detector function = peak, Trace = max hold.

For Below 1GHz

Use the following spectrum analyzer settings:

Span = wide enough to capture the peak level of the in-band emission and all spurious  
RBW = 100 KHz, VBW  $\geq$  RBW for peak measurement, Sweep = auto, Detector function = peak, Trace = max hold.

### Note:

- 1: The resolution bandwidth and video bandwidth of test receiver/spectrum analyzer is 120 KHz for Quasi-peak detection (QP) at frequency below 1GHz.
- 2: The resolution bandwidth of test receiver/spectrum analyzer is 1MHz and the video bandwidth is 3MHz for peak detection (PK) at frequency above 1GHz.
- 3: The resolution bandwidth of test receiver/spectrum analyzer is 1MHz and the video bandwidth is 3MHz for RMS Average ((duty cycle < 98%) for Average detection (AV) at frequency above 1GHz, then the measurement results was added to a correction factor ( $20\log(1/\text{duty cycle})$ ).
- 4: The resolution bandwidth of test receiver/spectrum analyzer is 1MHz and the video bandwidth is 10Hz (duty cycle > 98%) for Average detection (AV) at frequency above 1GHz.

## Limit

The radio emission outside the operating frequency band shall be at least 20 dB below that in the 100 kHz bandwidth within the band that contains the highest level of the desired power. Radiated emissions which fall in the restricted bands, as defined in section 15.205, must comply with the radiated emission limits specified in section 15.209.

Frequency MHz	Field Strength uV/m	Field Strength dBµV/m	Detector
30-88	100	40	QP
88-216	150	43.5	QP
216-960	200	46	QP
960-1000	500	54	QP
Above 1000	500	54	AV
Above 1000	5000	74	PK

## Spurious radiated emissions for transmitter

The only worse case (which is subject to the maximum EIRP, GFSK mode) test result is listed in the report.

### Transmitting spurious emission test result as below:

#### BT3.0 GFSK Modulation 2402MHz Test Result

Frequency Band	Frequency MHz	Emission Level dBuV/m	Polarization	Limit dBuV/m	Detector	Margin dBuV/m	Correct factor (dB)	Result
30-1000MHz	308.39	41.05	H	46	QP	4.95	-25.7	Pass
	280.80*	42.15	V	46	QP	3.85	-26.1	Pass
1000-25000MHz	4803.75*	47.59	H	74	PK	26.41	3.7	Pass
	--	--	H	54	AV	--	--	Pass
	4803.75*	46.48	V	74	PK	27.52	3.7	Pass
	--	--	V	54	AV	--	--	Pass

#### BT3.0 GFSK Modulation 2441MHz Test Result

Frequency Band	Frequency MHz	Emission Level dBuV/m	Polarization	Limit dBuV/m	Detector	Margin dBuV/m	Correct factor (dB)	Result
30-1000MHz	--	--	H	43.5	QP	--	--	Pass
	--	--	H	46	QP	--	--	Pass
1000-25000MHz	4881.10*	50.24	H	74	PK	23.76	3.8	Pass
	--	--	H	54	AV	--	--	Pass
	4881.56*	46.77	V	74	PK	27.23	3.8	Pass
	--	--	V	54	AV	--	--	Pass

## BT3.0 GFSK Modulation 2480MHz Test Result

Frequency Band	Frequency MHz	Emission Level dBuV/m	Polarization	Limit dBuV/m	Detector	Margin dBuV/m	Correct factor (dB)	Result
30-1000MHz	--	--	H	43.5	QP	--	--	Pass
	--	--	H	46	QP	--	--	Pass
1000-25000MHz	4959.38*	51.69	H	74	PK	22.31	4.3	Pass
	--	--	H	54	AV	--	--	Pass
	4959.84*	49.76	V	74	PK	24.24	4.3	Pass
	--	--	V	54	AV	--	--	Pass

## Remark:

- (1) “\*” means the emission(s) appear within the restrict bands shall follow the requirement of section 15.205.
- (2) Data of measurement within this frequency range shown “--” in the table above means the reading of emissions are the noise floor or attenuated more than 10dB below the permissible limits or the field strength is too small to be measured.
- (3) Above 1GHz: Corrector factor = Antenna Factor + Cable Loss- Amplifier Gain  
Below 1GHz: Corrector factor = Antenna Factor + Cable Loss

## 10 Test Equipment List

### List of Test Instruments

#### Radiated Emission Test

Description	Manufacturer	Model no.	Serial no.	cal. due date
EMI Test Receiver	Rohde & Schwarz	ESR 26	101269	2019-7-6
Trilog Super Broadband Test Antenna	Schwarzbeck	VULB 9163	707	2019-6-28
Horn Antenna	Rohde & Schwarz	HF907	102294	2019-6-28
Pre-amplifier	Rohde & Schwarz	SCU 18	102230	2019-7-6
Signal Generator	Rohde & Schwarz	SMY01	839369/005	2019-7-6
Attenuator	Agilent	8491A	MY39264334	2019-7-6
3m Semi-anechoic chamber	TDK	9X6X6	----	2020-7-7
Test software	Rohde & Schwarz	EMC32	Version 9.15.00	N/A

#### Conducted Emission Test

Description	Manufacturer	Model no.	Serial no.	cal. due date
EMI Test Receiver	Rohde & Schwarz	ESR 3	101782	2019-7-6
LISN	Rohde & Schwarz	ENV4200	100249	2019-7-6
LISN	Rohde & Schwarz	ENV432	101318	2019-7-6
LISN	Rohde & Schwarz	ENV216	100326	2019-7-6
ISN	Rohde & Schwarz	ENY81	100177	2019-7-6
ISN	Rohde & Schwarz	ENY81-CA6	101664	2019-7-6
High Voltage Probe	Rohde & Schwarz	TK9420(VT9420)	9420-584	2019-6-30
RF Current Probe	Rohde & Schwarz	EZ-17	100816	2019-6-30
Attenuator	Shanghai Huaxiang	TS2-26-3	080928189	2019-7-6
Test software	Rohde & Schwarz	EMC32	Version 9.15.00	N/A

#### RF Test

Description	Manufacturer	Model no.	Serial no.	cal. due date
Signal Analyzer	Rohde & Schwarz	FSV40	101030	2019-7-6

## 11 System Measurement Uncertainty

For a 95% confidence level, the measurement expanded uncertainties for defined systems, in accordance with the recommendations of ISO 17025 were:

System Measurement Uncertainty	
Test Items	Extended Uncertainty
Uncertainty for Conducted Emission 150kHz-30MHz (for test using AMN ENV432 or ENV4200)	3.21dB
Uncertainty for Radiated Spurious Emission 25MHz-3000MHz	Horizontal: 4.80dB; Vertical: 4.87dB;
Uncertainty for Radiated Spurious Emission 3000MHz-18000MHz	Horizontal: 4.59dB; Vertical: 4.58dB;
Uncertainty for Radiated Spurious Emission 18000MHz-40000MHz	Horizontal: 5.05dB; Vertical: 5.04dB;
Uncertainty for Conducted RF test	RF Power Conducted: 1.16dB Frequency test involved: 0.6×10 <sup>-7</sup> or 1%